Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10607020	HILL ET AL.
Examiner	Art Unit
Le Nguyen	2174

SEARCHED							
Class	Subclass	Date	Examiner				
715	752, 963	11/13/07	lvn				

SEARCH NOTES					
Search Notes	Date	Examiner			
confirmed allowance w/Sy Luu	6/21/07	lvn			
US-PGPub, USPAT: 715/751-753; 709/204-207	11/13/07	lvn			
EPO, JPO	11/13/07	lvn			
ACM library, IEEE Xplore	11/13/07	lvn			

INTERFERENCE SEARCH					
Class		Subclass	Date	Examiner	
715	752, 963		11/13/07	lvn	

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